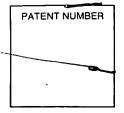
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Subclass	ISSUE CLASSIFICATION
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U.S. UTILITY Patent Application

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APPLICATION NO. CONT/PRIOR CLASS SUBCLASS ART UNIT EXAMINER
09/870736 F 250 286 MOUTET

Yoshiro Shiokawa Megumi Nakamura Tohru Sasaki Toshihiro Fujii

Method and apparatus for ion attachment mass spectrometry

TITLE

NESTABLISMITTS

PTO-204 12/99

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TERMINAL		DRAWINGS		CLAIMS ALLOWED		
LJ DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.	
☐ The term of this patent				NOTICE OF ALLOWANCE MAILED		
subsequent to (date) has been disclaimed.	(Assistant I	xaminer)	(Date)			
The term of this patent shall						
not extend beyond the expiration date of U.S Patent, No.				ISSUE FEE		
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this patent have been disclaimed.	(Legal Instrume	ents Examiner)	(Date)			
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orm PTO-436A Rev. 699)			FILED WITH:		FICHE CD-RO	

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